

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/716,316 NIE ET AL.	
		Examiner	Art Unit DAVID N. WERNER 2483	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0034246 A1	03-2002	Yamada et al.	375/240.03
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	D	US-			
	E	US-			
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